

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/742,458	WONG ET AL.	
Examiner		Art Unit		Page 1 of 3
BRETT FEENEY		3624		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,164,897 A	11-1992	Clark et al.	705/321
*	B	US-5,416,694 A	05-1995	Parrish et al.	705/8
*	C	US-5,696,702 A	12-1997	Skinner et al.	702/186
*	D	US-5,758,324 A	05-1998	Hartman et al.	705/1.1
*	E	US-5,765,140 A	06-1998	Knudson et al.	705/9
*	F	US-5,832,497 A	11-1998	Taylor, Jeffrey C.	705/321
*	G	US-5,884,272 A	03-1999	Walker et al.	705/319
*	H	US-5,884,270 A	03-1999	Walker et al.	705/321
*	I	US-5,907,829 A	05-1999	Kida, Koji	705/9
*	J	US-5,963,914 A	10-1999	Skinner et al.	705/11
*	K	US-5,978,768 A	11-1999	McGovern et al.	705/321
*	L	US-5,978,767 A	11-1999	Chriest et al.	705/328
*	M	US-6,049,776 A	04-2000	Donnelly et al.	705/8

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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<b>Notice of References Cited</b>		Application/Control No. 09/742,458	Applicant(s)/Patent Under Reexamination WONG ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,266,659 B1	07-2001	Nadkarni, Uday P.	1/1
*	B	US-6,275,812 B1	08-2001	Haq et al.	705/11
*	C	US-6,289,340 B1	09-2001	Puram et al.	1/1
*	D	US-6,301,574 B1	10-2001	Thomas et al.	1/1
*	E	US-2002/0010614 A1	01-2002	Arrowood, Bryce A.	705/9
*	F	US-2002/0046074 A1	04-2002	Barton, Timothy	705/8
*	G	US-6,370,510 B1	04-2002	McGovern et al.	705/321
*	H	US-6,385,620 B1	05-2002	Kurzius et al.	1/1
*	I	US-6,408,337 B1	06-2002	Dietz et al.	709/229
*	J	US-2002/0111958 A1	08-2002	Hartman et al.	707/200
*	K	US-6,567,784 B2	05-2003	Bukow, Hans Max Theodore	705/9
*	L	US-6,574,605 B1	06-2003	Sanders et al.	705/8
*	M	US-6,591,246 B1	07-2003	Tuttle, Doreen M.	705/11

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,662,194 B1	12-2003	Joao, Raymond Anthony	1/1
*	B	US-6,718,341 B1	04-2004	Berstis et al.	1/1
*	C	US-6,742,002 B2	05-2004	Arrowood, Bryce A.	1/1
*	D	US-6,751,650 B1	06-2004	Finch et al.	709/203
*	E	US-6,785,679 B1	08-2004	Dane et al.	1/1
*	F	US-6,810,383 B1	10-2004	Loveland, James B.	705/9
*	G	US-7,069,229 B1	06-2006	Richardson et al.	705/9
*	H	US-7,457,764 B1	11-2008	Bullock et al.	705/8
*	I	US-7,490,086 B2	02-2009	Joao, Raymond Anthony	1/1
J	US-				
K	US-				
L	US-				
M	US-				

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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